



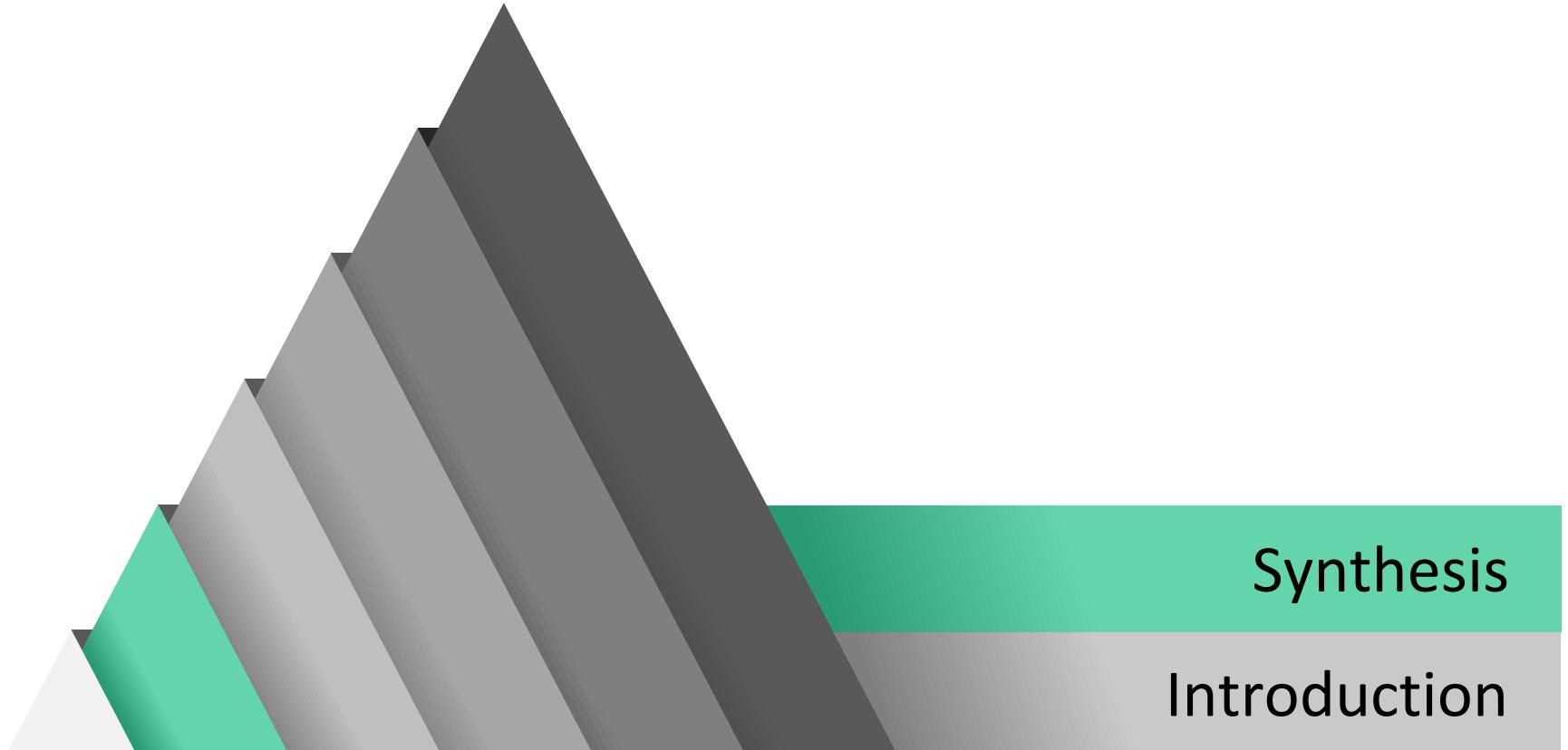
Thermoelectric properties of oxysulfide $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ compounds

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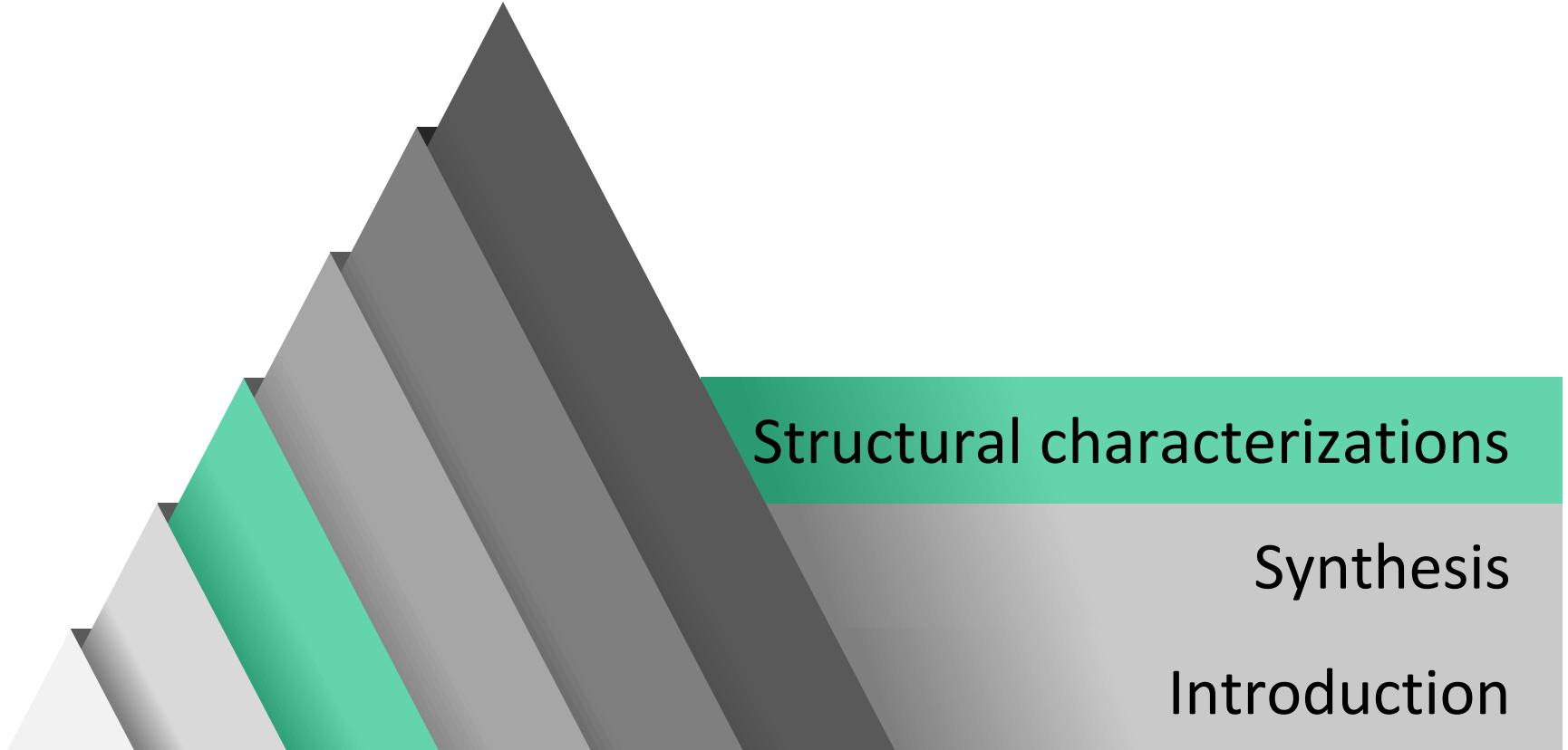
Plan



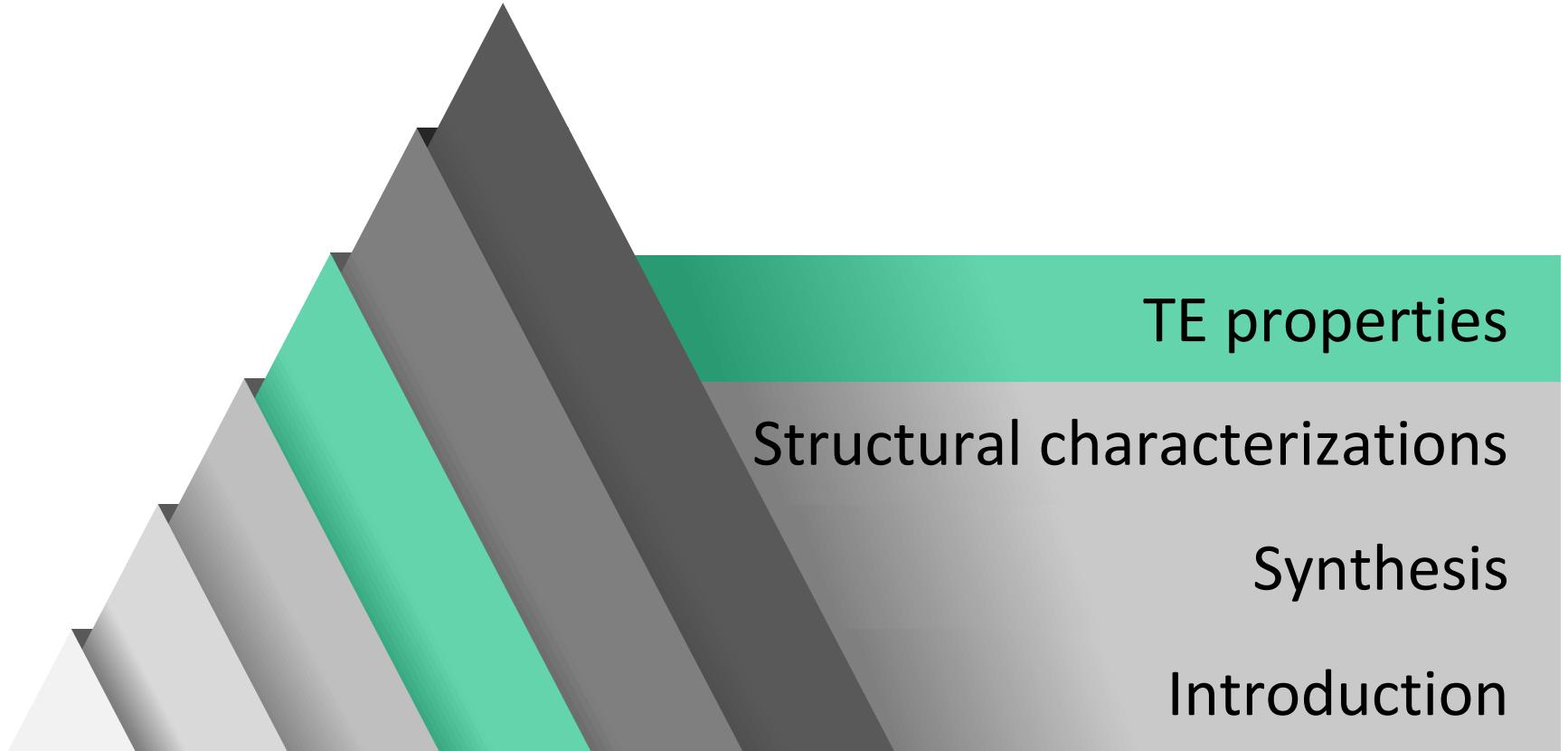
Plan



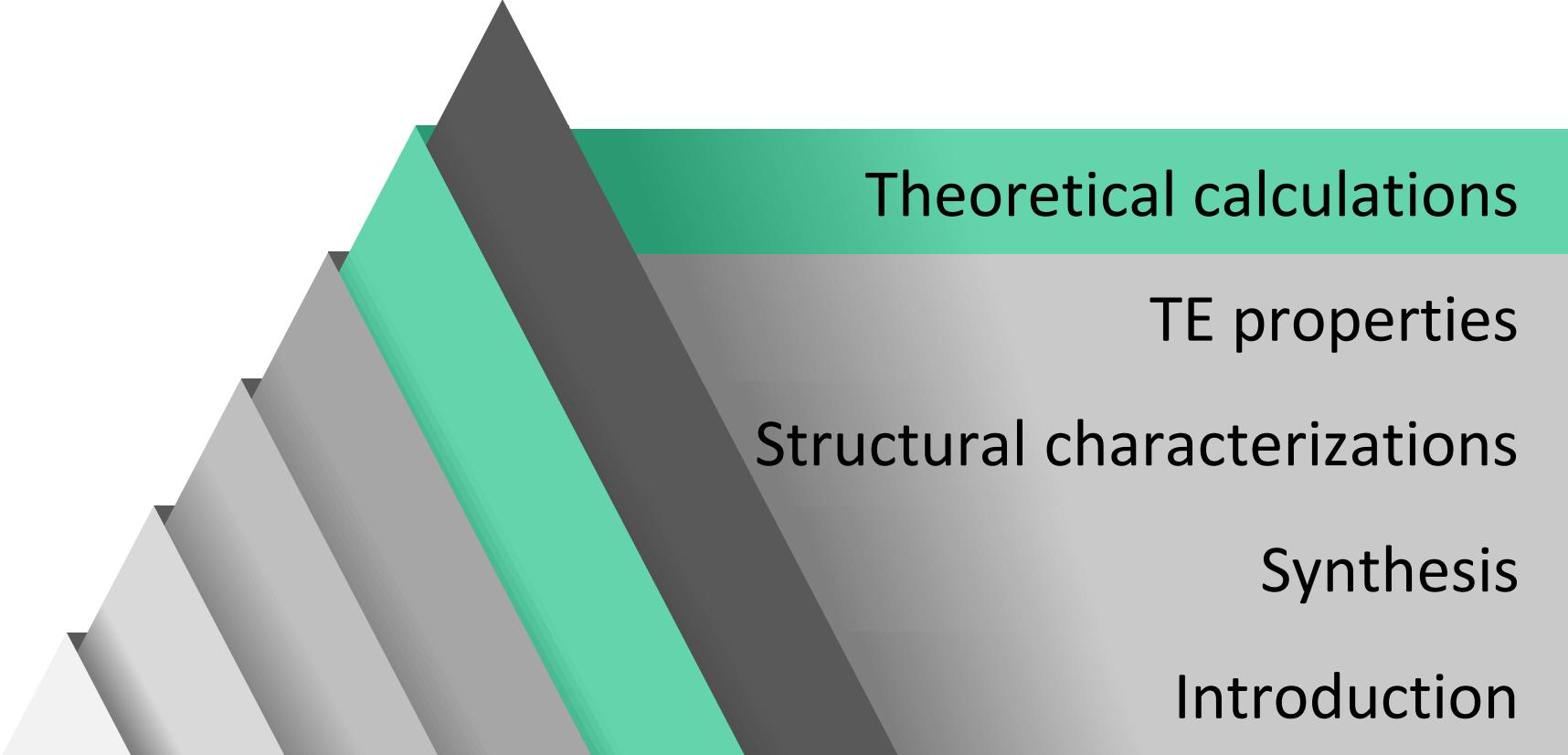
Plan



Plan



Plan



Theoretical calculations

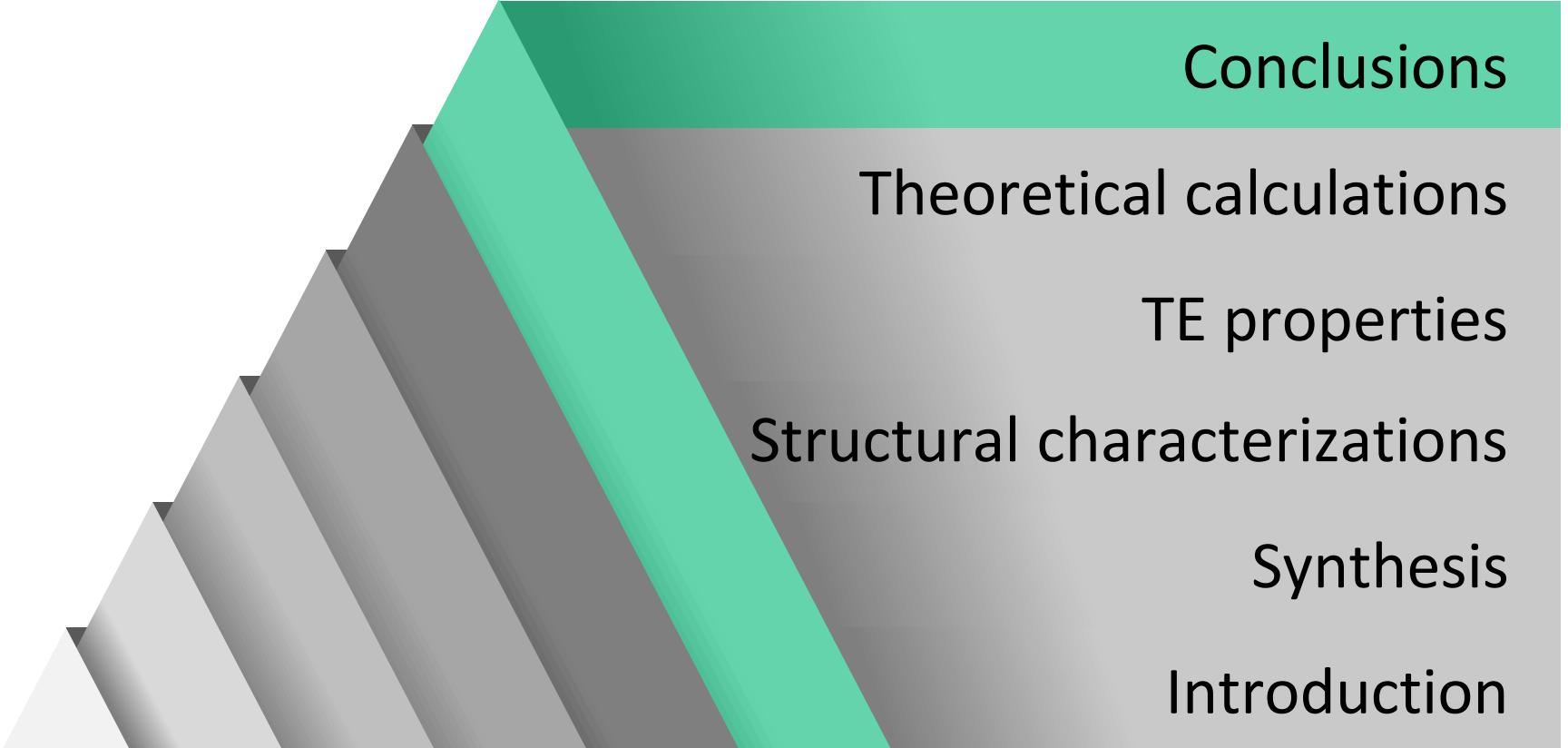
TE properties

Structural characterizations

Synthesis

Introduction

Plan



Conclusions

Theoretical calculations

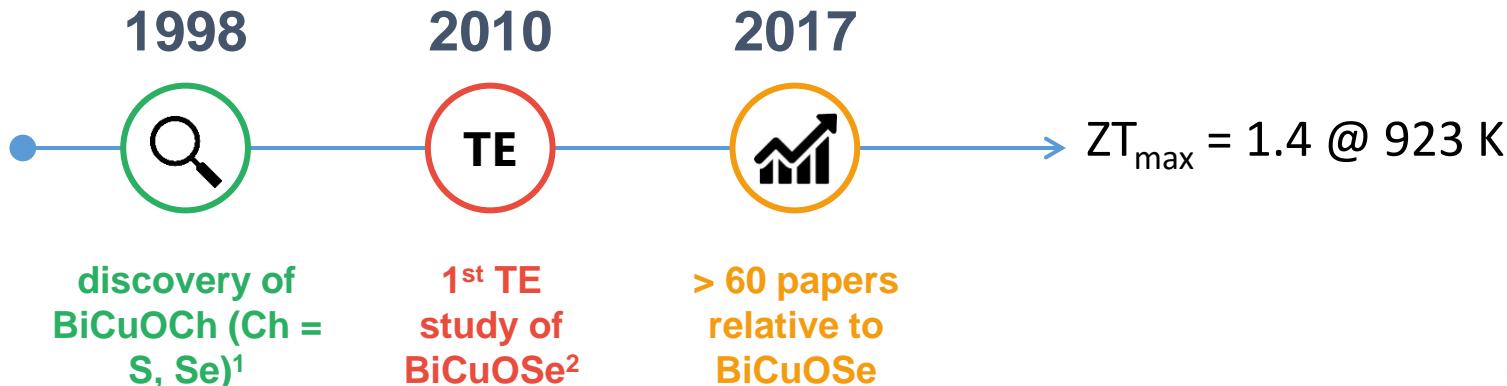
TE properties

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Introduction

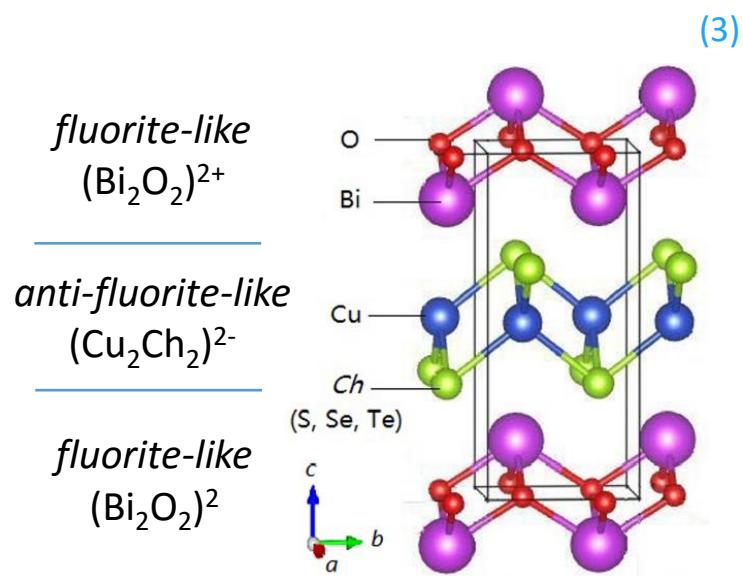


Structure:

tetragonal, ZrSiCuAs type ($P4/nmm$)

- 2 layers alternately stacked along c
- covalent bonding inside the layers⁽⁴⁾
- ionic bonding between the blocks

anisotropy of electrical and thermal properties
low thermal conductivity



(1) Kusainova, A. M. et al. *J. Solid State Chem.* **1994**, *112*, 189–191. (3) Liu, G. et al. *J. Appl. Phys.* **2016**, *119*, 185109.

(2) Zhao, L. D. et al. *Appl. Phys. Lett.* **2010**, *97*, 092118. (4) Shein, I. R. et al. *Solid State Commun.* **2010**, *150* (13-14), 640–643. 3

Introduction

BiCuOCh (Ch = S, Se, Te) → copper vacancies → p-type⁽¹⁾

(3,4)

| | BiCuOSe | BiCuOS |
|--|---------|-------------------|
| gap (eV) | 0.8 | 1.1 |
| ρ_{RT} (mΩ cm) | ~ 200 | ~ 8×10^5 |
| κ_{RT} (W m ⁻¹ K ⁻¹) | 1.05 | 1.1 |
| ZT _{max} (673 K) | 0.31 | 0.07 |

TE properties of BiCuOSe:

- stable in medium temperature range
- numerous successful substitutions : Ba²⁺, Sr²⁺, Mg²⁺, Ca²⁺, Pb²⁺...
- when substituted and textured : ZT_{max} = 1.4 @ 923 K⁽²⁾

→ Lack of studies on BiCuOS due to high resistivity

(1) Ueda, K. et al. *Thin Solid Films* **2002**, 411, 115–118.

(2) Sui, J. et al. *Energy Environ. Sci.* **2013**, 6, 2916–2920.

(3) Bérardan, D. et al. *Materials*. **2015**, 8, 1043–1058.

(4) Zhu, H. et al. *J. Eur. Ceram. Soc.* **2017**, 37, 1541–1546.

Synthesis



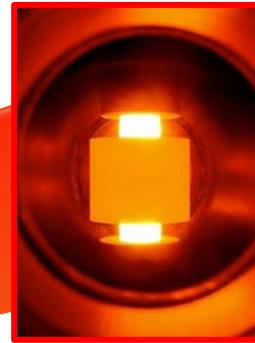
Bi_2O_3 , Bi, Cu,
S, (PbO)



Mechanosynthesis

- synthesized in 3 h vs sealed tubes (> 10 h) or hydrothermal synthesis (> 55 h)^(1,2)

- scalable for mass production

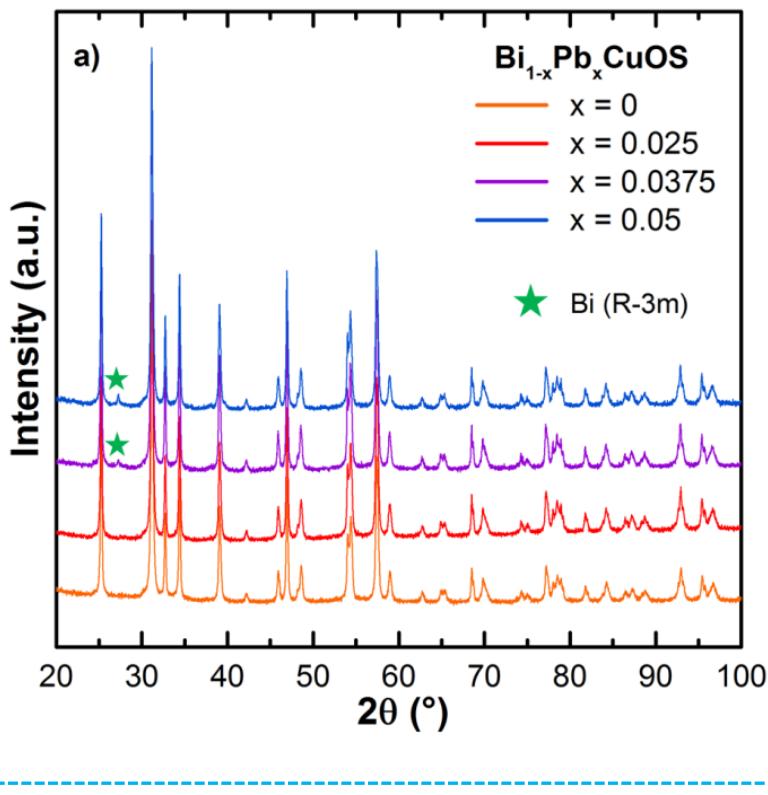


Spark Plasma
Sintering

- short process duration, high density

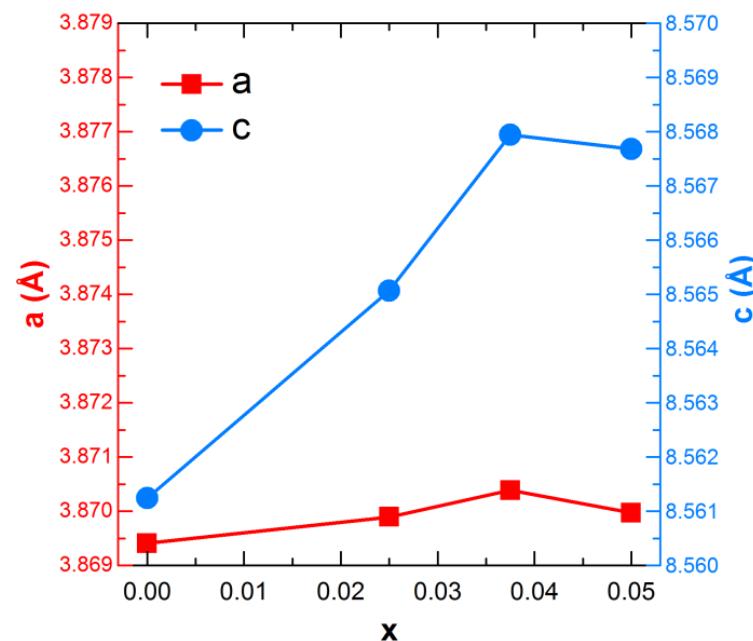
475 °C 25 min
4'45'' 4'45''
pressure : 64 MPa

Structural characterizations of $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ ($0 \leq x \leq 0.05$)



powder XRD after sintering :

- $x \leq 0.025$: single phase
- $x \geq 0.0375$: presence of ~ 1 % Bi metal

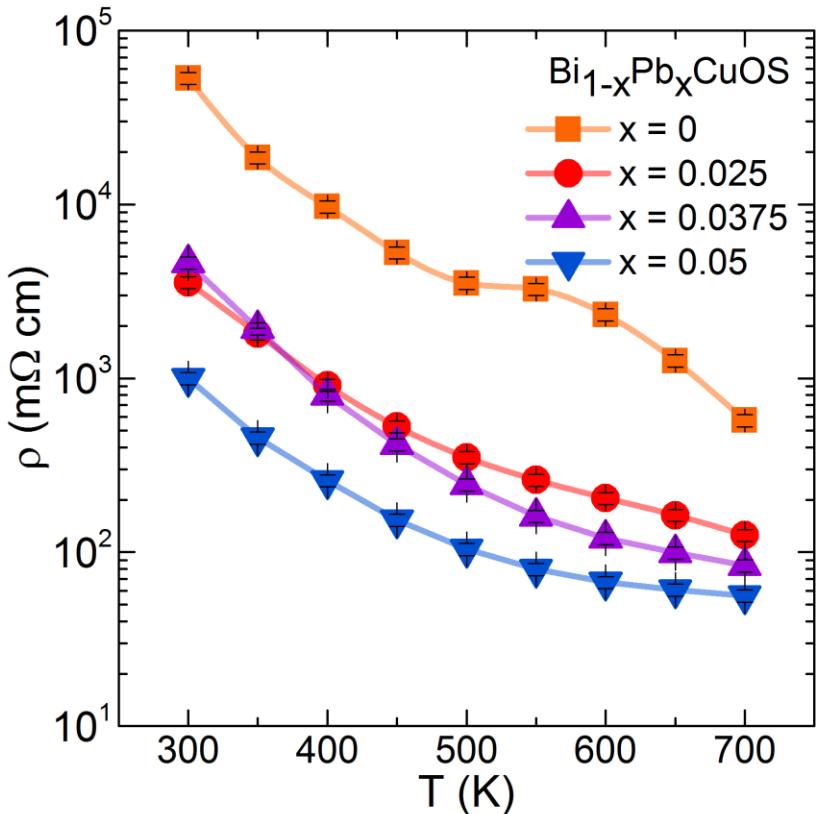


cell parameters (from Rietveld refinements) :

when $x \nearrow$:

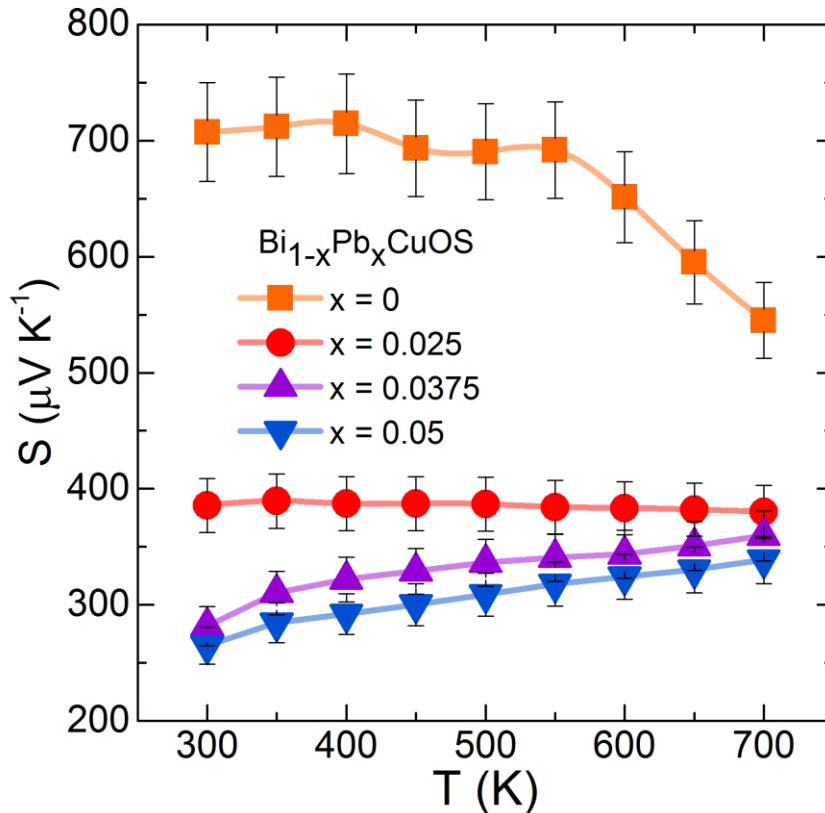
- a and $c \nearrow \rightarrow$ substitution of Pb^{2+} (129 pm) on Bi^{3+} (117 pm) site
- c increases more than $a \rightarrow$ weakening of Coulombic attraction between the layers
[($\text{Bi}_{1-x}\text{Pb}_x$)₂O₂]^{(2-2x)+} and [Cu_2S_2]^{(2-2x)-} (1)

TE properties of $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ ($0 \leq x \leq 0.05$)



- when $x \nearrow : \rho \searrow$

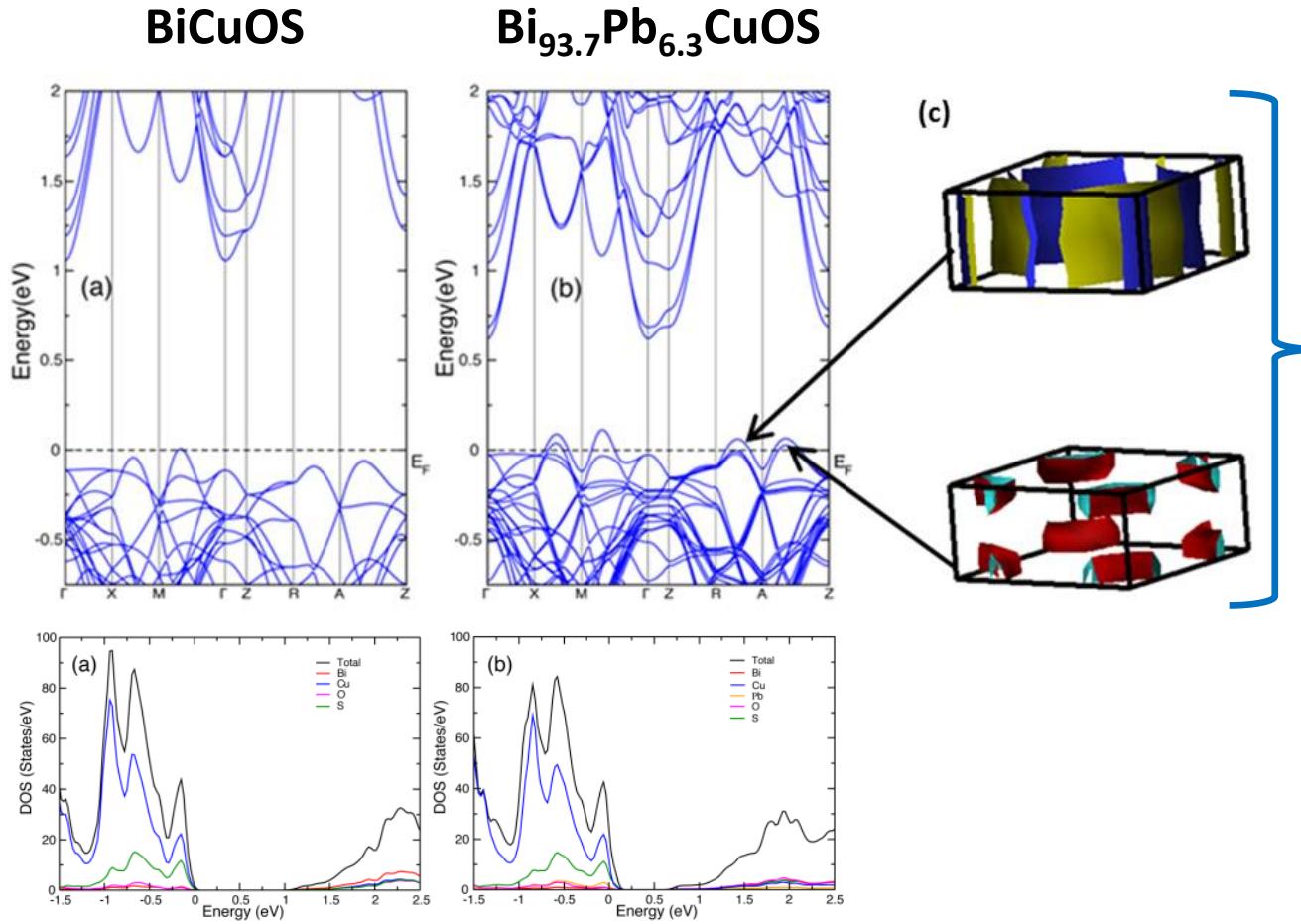
• $\rho_{x=0.05} = 56 \text{ m}\Omega \text{ cm} @ 700 \text{ K}$



- when $x \nearrow : S \searrow$

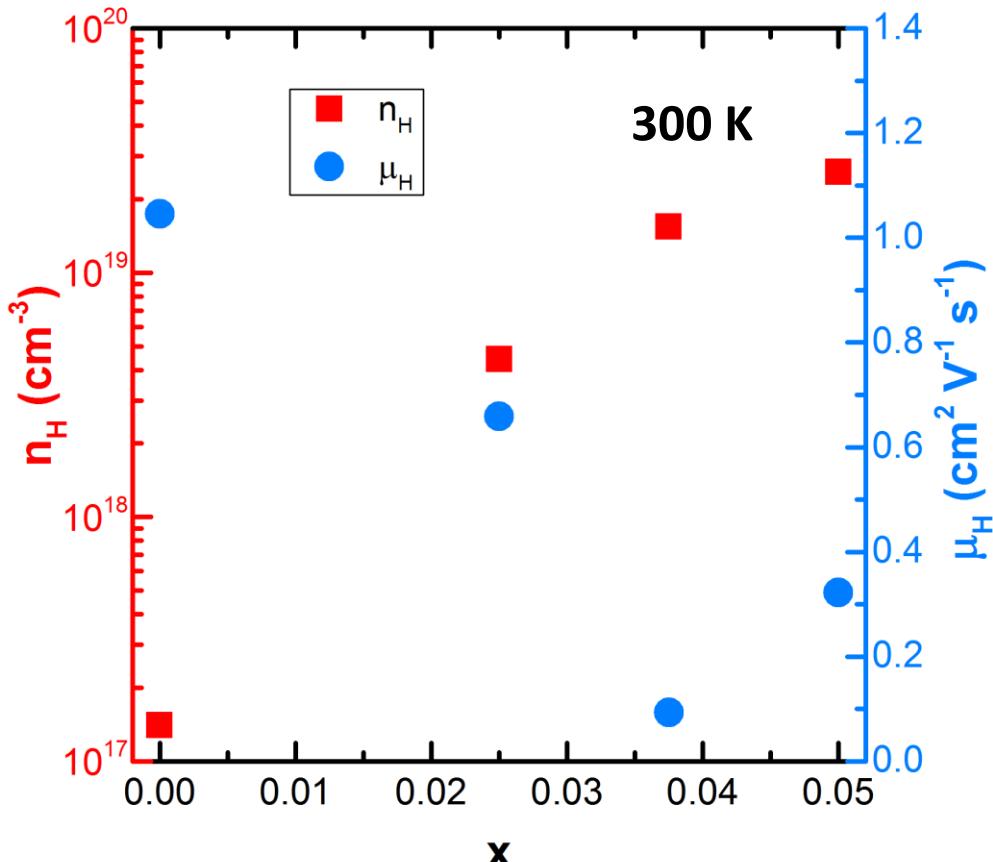
• $S_{x=0.05} = 340 \mu\text{V K}^{-1} @ 700 \text{ K}$

DFT calculations



- band-gap decreases with Pb-doping
- top of VB : - hybridization between Cu 3d and S 3p
 - contribution of Pb 6s in Pb-doped samples

TE properties of $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ ($0 \leq x \leq 0.05$)



when $x \nearrow :$

- $n \nearrow \rightarrow$ confirms Pb^{2+} substitution
- n reaches $2.6 \times 10^{19} \text{ cm}^{-3}$ ($x = 0.05$)

too low to reach optimal PF

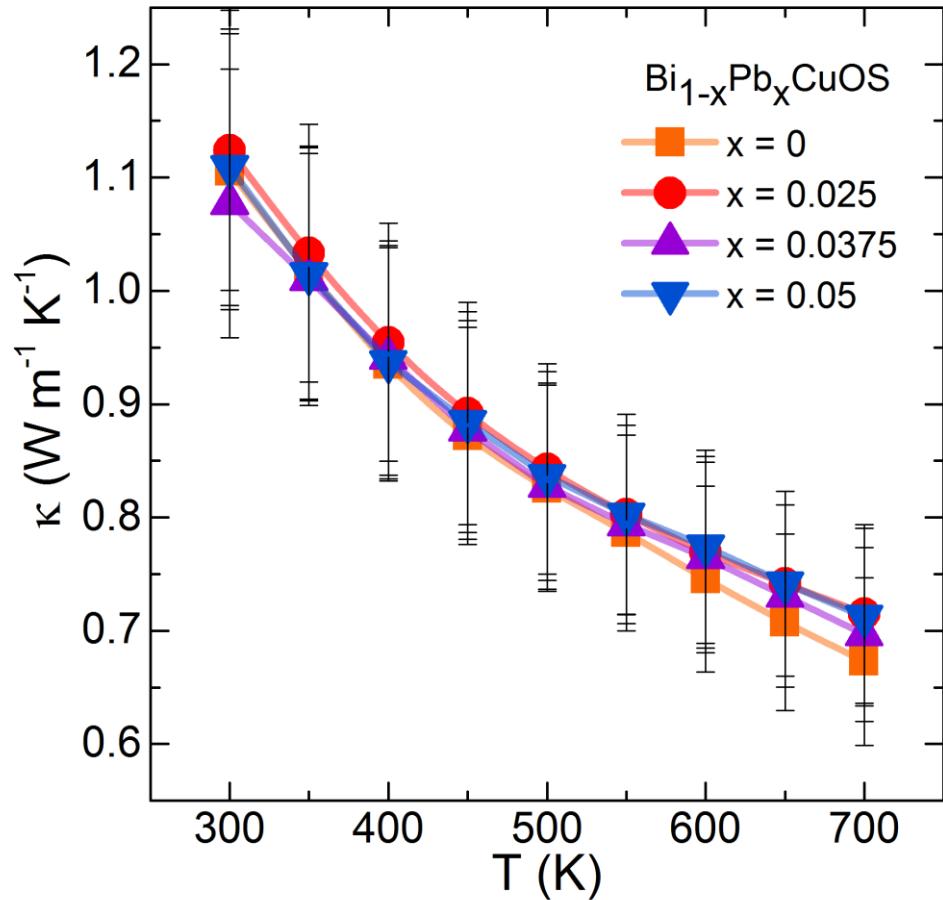
- $\mu \downarrow$ until $0.3 \text{ cm}^2 \text{V}^{-1} \text{s}^{-1}$ ($x = 0.05$)

low mobility

hole effective mass estimated from Seebeck coefficient and the carrier concentration :

| x | 0 | 0.025 | 0.0375 | 0.05 |
|-----------|------|-------|--------|------|
| m^*/m_e | 1.71 | 1.81 | 1.85 | 2.2 |

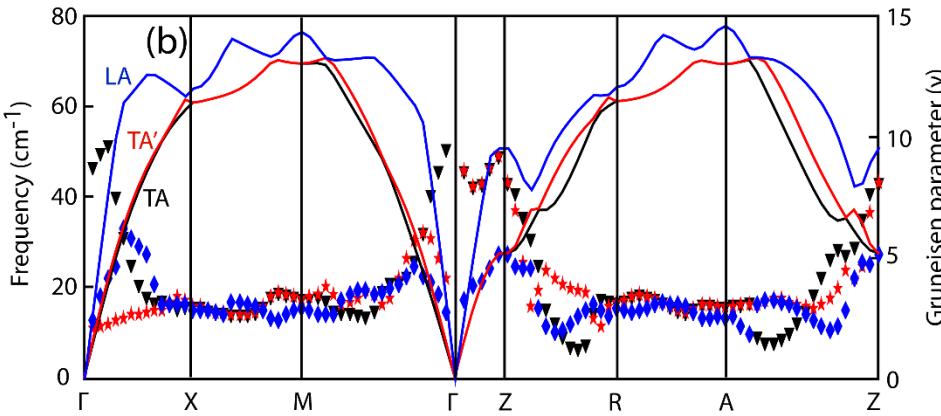
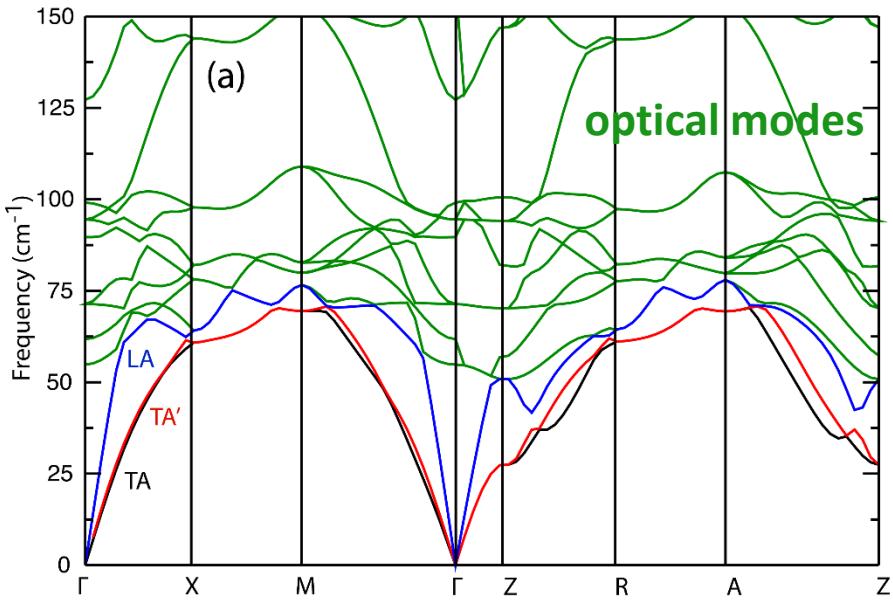
TE properties of $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ ($0 \leq x \leq 0.05$)



- when $x \nearrow$: κ remains constant
Bi/Pb:
 - low mass fluctuation
 - moderate size mismatch
- low κ ($\kappa_l \gg \kappa_e$) \rightarrow layered structure, strong phonon scattering

↗ $\kappa_{700\text{ K}} \sim 0.70 \text{ W m}^{-1} \text{ K}^{-1}$

Thermal conductivity of BiCuOS



phonon dispersion of BiCuOS:

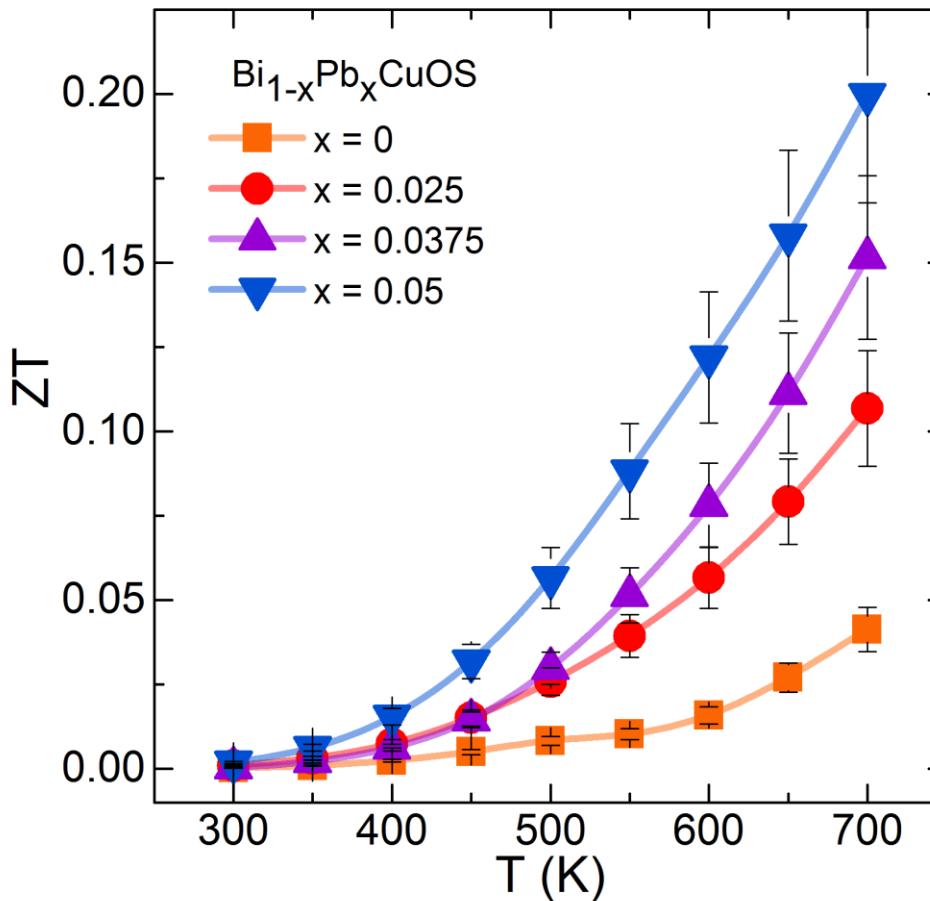
- 3 acoustic modes with low boundary frequency
 65 cm^{-1} along Γ -X and Γ -M
 50 cm^{-1} along Γ -Z (001 direction)

weak inter-layers bonding

Grüneisen parameters of BiCuOS :

- ~ 8 along Γ -Z
- strong anharmonicity between the layers

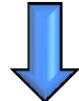
TE properties of $\text{Bi}_{1-x}\text{Pb}_x\text{CuOS}$ ($0 \leq x \leq 0.05$)



- when $x \nearrow : n \nearrow$ and $\rho \searrow \rightarrow ZT \nearrow$
- $ZT = 0.2$ @ 700 K with **5 at%** Pb **Best value among the oxysulfides**

Conclusions

XRD + charge carrier concentration  confirms Pb^{2+} substitution



~ 1 % Bi secondary phase when $x \geq 0.0375$

when $x = 0.05$: charge carrier concentration  $\times 185$ at RT


resistivity


 divided by 53 at RT

 remains too high to reach optimal PF


low thermal conductivity



 $ZT = 0.2$ @ 700 K with 5 at% Pb

Acknowledgements



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